



Sense Amplifiers

LM5520/LM7520 series dual core memory sense amplifiers general description

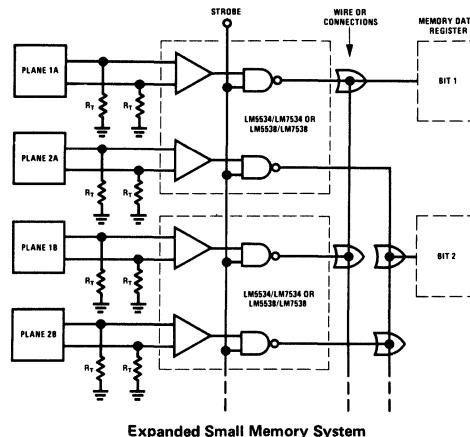
The devices in this series of dual core sense amplifiers convert bipolar millivolt-level memory sense signals to saturated logic levels. The design employs a common reference input which allows the input threshold voltage level of both amplifiers to be adjusted. Separate strobe inputs provide time discrimination for each channel. Logic inputs and outputs are DTL/TTL compatible. All devices of the series have identical preamplifier configurations, while various logic connections are provided to suit the specific application.

The LM5520/LM7520 has output latch capability and provides sense, strobe, and memory function for two sense lines. The LM5522/LM7522 contains a single open collector output which may be used to expand the number of inputs of the LM5520/LM7520, or to drive an external Memory Data Register (MDR). Intended for small memories, the two channels of the LM5524/LM7524 are independent with two separate outputs. The LM5534/LM7534 is similar to the LM5524/LM7524 but has uncommitted, wire-ORable outputs. The LM5528/LM7528 has the same logic configuration of the LM5524/LM7524 and in addition provides separate low impedance Test Points at each preamplifier output. A similar device having uncommitted, wire-ORable outputs is the LM5538/LM7538.

features

- High speed
- Guaranteed narrow threshold uncertainty over temperature

typical application



LM5520/LM7520 and LM5521/LM7521 electrical characteristics

LM5520/LM5521: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)								COMMENTS
					DIFF. INPUT	REF. INPUT	STROBE INPUT	GATE Q INPUT	GATE \bar{Q} INPUT	LOGIC OUTPUT (NOTE 3)	SUPPLY VOLT.		
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8) 35(33)	15 40 40	20(22) 45(47)	mV mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV 40 mV	+5V +5V +5V +5V	+5V +5V +5V +5V		+16 mA(Q) -400 $\mu\text{A}(Q)$ +16 mA(Q) -400 $\mu\text{A}(Q)$	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output <0 4V Logic Output >2 4V Logic Output <0 4V Logic Output >2 4V	
Differential & Reference Input Bias Current	30	100	μA	0V	0V	+5 25V	+5 25V	+5 25V			$\pm 5.25\text{V}$		

LM7520/LM7521: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 4)	11(8) 36(33)	15 40 40	19(22) 44(47)	mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV 40 mV	+5V +5V +5V +5V	+5V +5V +5V +5V		+16 mA(Q) -400 $\mu\text{A}(Q)$ +16 mA(Q) -400 $\mu\text{A}(Q)$	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output <0 4V Logic Output >2 4V Logic Output <0.4V Logic Output >2 4V	
Differential & Reference Input Bias Current	30	75	μA	0V	0V	+5 25V	+5 25V	+5 25V			$\pm 5.25\text{V}$		

LM5520/LM5521: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7520/LM7521: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Offset Current		0 5			μA	0V	0V	+5 25V	+5 25V	+5 25V		$\pm 5.25\text{V}$	
Logic "1" Input Voltage (Strobes)	2				V	40 mV	20 mV	+2V	+4 75V		-400 $\mu\text{A}(Q)$ +16 mA(Q)	$\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output >2 4V Logic Output <0.4V
(Gate Q)	2				V	40 mV	20 mV	0V	+2V		+16 mA(\bar{Q})	$\pm 5\text{V}$	Logic Output <0 4V
Logic "0" Input Voltage (Strobes)		0 8			V	40 mV	20 mV	+0 8V	+4 75V		+16 mA(Q)	$\pm 5\text{V}$	Logic Output <0.4V
(Gate Q)		0 8			V	40 mV	20 mV	0V	+0 8V		-400 $\mu\text{A}(Q)$	$\pm 5\text{V}$	Logic Output >2 4V
Logic "0" Input Voltage (Gate \bar{Q})		0 8			V	40 mV	20 mV	0V	+0 8V		-400 $\mu\text{A}(\bar{Q})$	$\pm 5\text{V}$	Logic Output >2 4V
Logic "0" Input Current	-1	-1 6			mA	40 mV	20 mV	+0 4V	+0 4V	+0 4V		$\pm 5.25\text{V}$	Each Input
Logic "1" Input Current (Strobe & Gate \bar{Q})	5 02	40 1			μA	0V	20 mV	+2 4V	+5 25V	+2 4V		$\pm 5.25\text{V}$	Each Input
(Gate Q)	5 02	40 1			μA	40 mV	20 mV	+5 25V	+5 25V	+2 4V		$\pm 5.25\text{V}$	Each Input
Logic "1" Output Voltage (Strobe)	2 4	3 9			V	40 mV	20 mV	+2 0V	+5 25V	+0 8V	-400 $\mu\text{A}(Q)$ -400 $\mu\text{A}(\bar{Q})$	$\pm 4.75\text{V}$ $\pm 4.75\text{V}$	
(Gate Q)	2 4	3 9			V	40 mV	20 mV	+0 8V	0V	+0 8V	-400 $\mu\text{A}(Q)$ -400 $\mu\text{A}(\bar{Q})$	$\pm 4.75\text{V}$ $\pm 4.75\text{V}$	
Logic "0" Output Voltage (Gate Q)	2 4	3 9			V	40 mV	20 mV	+4 75V	+5 25V	+2 0V	+16 mA(Q) +16 mA(\bar{Q})	$\pm 4.75\text{V}$ $\pm 4.75\text{V}$	
(Gate \bar{Q})	0 25	0 40			V	40 mV	20 mV	+0 8V	+4 75V	+2 0V	+16 mA(Q) +16 mA(\bar{Q})	$\pm 4.75\text{V}$ $\pm 4.75\text{V}$	
Q Output Short Circuit Current	-3	-4	-5		mA	0V	20 mV	0V	0V	0V	0 V(Q)	$\pm 5.25\text{V}$	
\bar{Q} Output Short Circuit Current	-2 1	-2 8	-3 5		mA	0V	20 mV	0V	0V	0V	0 V(\bar{Q})	$\pm 5.25\text{V}$	
V+ Supply Current	21	35			mA	0V	20 mV	0V	0V	0V		$\pm 5.25\text{V}$	
V- Supply Current	-13	-18			mA	0V	20 mV	0V	0V	0V		$\pm 5.25\text{V}$	

Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5520 and LM5521 are guaranteed the same as LM7520 and LM7521, respectively.

Note 2: Limits in parentheses pertain to LM5521, other limits pertain to LM5520.

Note 3: Q or \bar{Q} in parentheses indicate Q or \bar{Q} logic output, respectively.

Note 4: Limits in parentheses pertain to LM7521, other limits pertain to LM7520.

Note 5: Positive current is defined as current into the referenced pin.

Note 6: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.

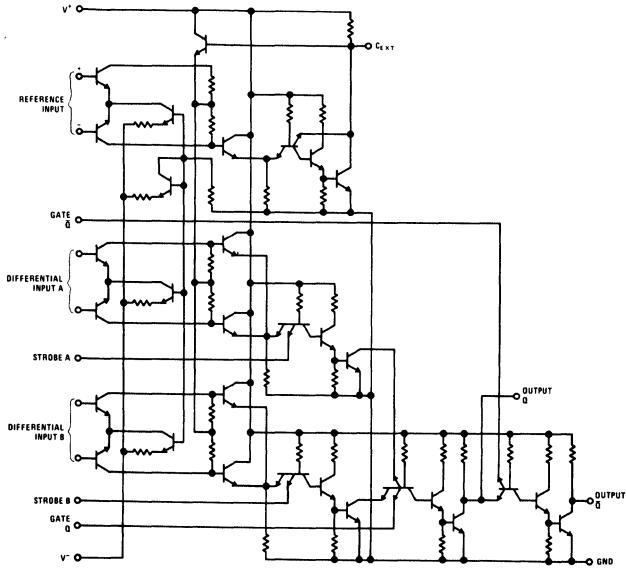
LM5520/LM7520 and LM5521/LM7521 electrical characteristics

LM5520/LM5521 and LM7520/LM7521: The following apply for $T_A = 25^\circ\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

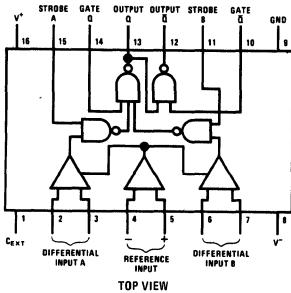
PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS				
					DIFF. INPUT	REF. INPUT	STROBE AND GATE INPUTS	Q LOGIC OUTPUT	AC TEST CIRCUIT
AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE	
Propagation Delays									
Differential Input to Logical "1" Q Output	20	40	ns		20 mV				1
Differential Input to Logical "0" Q Output	28		ns		20 mV				1
Differential Input to Logical "1" \bar{Q} Output	36		ns		20 mV				1
Differential Input to Logical "0" \bar{Q} Output	28	55	ns		20 mV				1
Strobe Input to Logical "1" Q Output	10	30	ns		20 mV				1
Strobe Input to Logical "0" Q Output	20		ns		20 mV				1
Strobe Input to Logical "1" \bar{Q} Output	33		ns		20 mV				1
Strobe Input to Logical "0" \bar{Q} Output	16	55	ns		20 mV				1
Gate Q Input to Logical "1" Q Output	12	20	ns		20 mV				2
Gate Q Input to Logical "0" Q Output	6		ns		20 mV				2
Gate Q Input to Logical "1" \bar{Q} Output	17		ns		20 mV				2
Gate Q Input to Logical "0" \bar{Q} Output	19	30	ns		20 mV				2
Gate \bar{Q} Input to Logical "1" \bar{Q} Output	12		ns		20 mV				2
Gate \bar{Q} Input to Logical "0" \bar{Q} Output	6	20	ns		20 mV				2
Diff. Input Overload Recovery Time	10		ns						
Common-Mode Input Overload Recovery Time	5		ns						
Min. Cycle Time	200		ns						

LM5520/LM7520 and LM5521/LM7521

schematic diagram



connection diagram



Order Number LM5520J or LM7520J

See Package 17

Order Number LM7520N

See Package 23

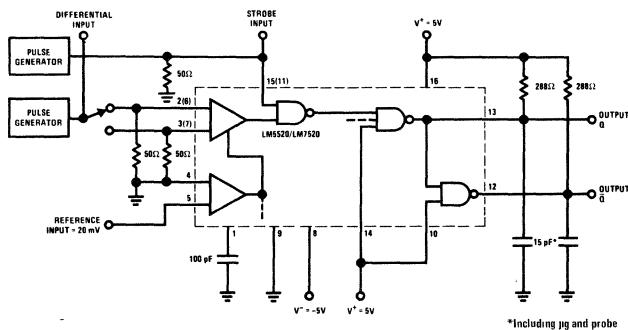
Order Number LM5521J or LM7521J

See Package 17

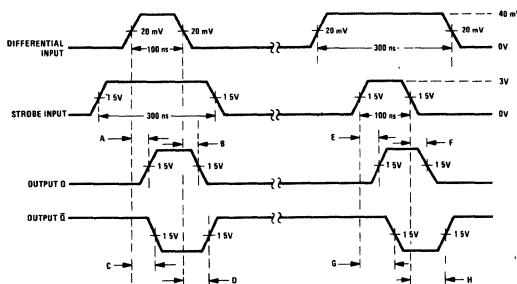
Order Number LM7521N

See Package 23

LM5520/LM7520 and LM5521/LM7521 AC test circuit (1)

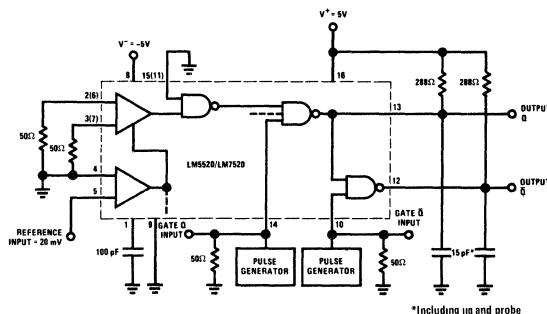


voltage waveforms (1)

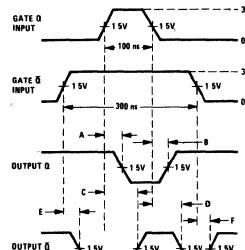


- 1 Pulse generator characteristics
 $Z_{out} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz
- 2 Propagation delays
 - A = Differential input to logical "1" output Q
 - B = Differential input to logical "0" output Q̄
 - C = Differential input to logical "0" output Q̄
 - D = Differential input to logical "1" output Q
 - E = Strobe input to logical "1" output Q
 - F = Strobe input to logical "0" output Q̄
 - G = Strobe input to logical "0" output Q̄
 - H = Strobe input to logical "1" output Q

AC test circuit (2)



voltage waveforms (2)



- 1 Pulse generator characteristics
 $Z_{out} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz
- 2 Propagation delays
 - A = Gate Q input to logical "0" output Q
 - B = Gate Q input to logical "1" output Q
 - C = Gate Q input to logical "1" output Q
 - D = Gate Q input to logical "0" output Q
 - E = Gate Q̄ input to logical "0" output Q̄
 - F = Gate Q̄ input to logical "1" output Q

LM5522/LM7522 and LM5523/LM7523 electrical characteristics

LM5522/LM5523: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)								COMMENTS
					DIFF. INPUT	REF. INPUT	STROBE INPUT	GATE INPUT	LOGIC OUTPUT	SUPPLY VOLT.			
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8) 35(33)	15 40	20(22) 45(47)	mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV 40 mV	+5V +5V +5V +5V	+5V +5V +5V +5V	-400 μA +16 mA -400 μA +16 mA	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output >2 4V Logic Output <0 4V Logic Output >2 4V Logic Output <0 4V	
Differential & Reference Input Bias Current	30	100	μA	0V	0V	+5 25V	+5 25V			$\pm 5.25\text{V}$			

LM7522/LM7523: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8) 36(33)	15 40	19(22) 44(47)	mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV 40 mV	+5V +5V +5V +5V	+5V +5V +5V +5V	-400 μA +16 mA -400 μA +16 mA	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output >2.4V Logic Output <0.4V Logic Output >2.4V Logic Output <0.4V	
Differential & Reference Input Bias Current	30	75	μA	0V	0V	+5 25V	+5.25V			$\pm 5.25\text{V}$		

LM5522/LM5523: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7522/LM7523: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Diff. Input Offset Current		0.5		μA	0V	0V	+5.25V	+5.25V		$\pm 5.25\text{V}$		
Logic "1" Input Voltage (Strobes) (Gate)	2			V	40 mV	20 mV	+2V	+4.75V	+16 mA	$\pm 5\text{V}$	$\pm 5\text{V}$	Logic Output <0 4V Logic Output >2 4V
Logic "0" Input Voltage (Strobes) (Gate)	2		0.8	V	40 mV	20 mV	0V	+0.8V	+4.75V	-400 μA	$\pm 5\text{V}$	Logic Output >2.4V Logic Output <0.4V
Logic "0" Input Current			0.8	V	40 mV	20 mV	+0.8V	+0.8V	-400 μA	$\pm 5\text{V}$	$\pm 5\text{V}$	
Logic "1" Input Current (Strobes)		-1	-1.6	mA	40 mV	20 mV	+0 4V	+0 4V	+16 mA	$\pm 5.25\text{V}$		Each Input
(Gate)		40	1	μA	0V	20 mV	+2.4V	+5.25V	$\pm 5.25\text{V}$		$\pm 5.25\text{V}$	
Logic "1" Input Current (Gate)		40	1	μA	40 mV	20 mV	+5.25V	+2.4V	$\pm 5.25\text{V}$		$\pm 5.25\text{V}$	
Logic "1" Output Voltage	2.4	3.9		V	40 mV	20 mV	+0.8V	+2V	-400 μA	$\pm 4.75\text{V}$		
Logic "0" Output Voltage (Strobes) (Gate)		0.25	0.40	V	40 mV	20 mV	+2V	+4.75V	+16 mA	$\pm 4.75\text{V}$	$\pm 4.75\text{V}$	Tie Pins 10 and 12
Output Short Circuit Current		0.25	0.40	V	40 mV	20 mV	0V	+0.8V	+16 mA	$\pm 4.75\text{V}$	$\pm 4.75\text{V}$	Tie Pins 10 and 12
Output Leakage Current	-2.1	-2.8	-3.5	mA	40 mV	20 mV	0V	+5.25V	0V	$\pm 5.25\text{V}$	$\pm 5.25\text{V}$	
V^+ Supply Current		0.01	250	μA	0V	20 mV	0V	+2V	+5.25V	$\pm 4.75\text{V}$	$\pm 4.75\text{V}$	
V^- Supply Current		23	36	mA	0V	20 mV	0V	0V	0V	$\pm 5.25\text{V}$	$\pm 5.25\text{V}$	
Min. Cycle Time		-13	-18	ns	0V	20 mV	0V	0V	0V	$\pm 5.25\text{V}$	$\pm 5.25\text{V}$	

LM5522/LM5523 and LM7522/LM7523: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	+5V	SCOPE			
Propagation Delays Differential Input to Logical "1" Output		26		ns		20 mV						AC Test Circuit
Differential Input to Logical "0" Output		21	45	ns		20 mV						AC Test Circuit
Strobe Input to Logical "1" Output		22		ns		20 mV						AC Test Circuit
Strobe Input to Logical "0" Output		12	40	ns		20 mV						AC Test Circuit
Gate Input to Logical "1" Output		4		ns		20 mV						AC Test Circuit
Gate Input to Logical "0" Output		15	25	ns		20 mV						AC Test Circuit
Differential Input Overload Recovery Time		10		ns								
Common Mode Input Overload Recovery Time		5		ns								
Min. Cycle Time		200		ns								

Note 1. For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5522 and LM5523 are guaranteed the same as LM7522 and LM7523, respectively

Note 2: Limits in parentheses pertain to LM5523, other limits pertain to LM5522

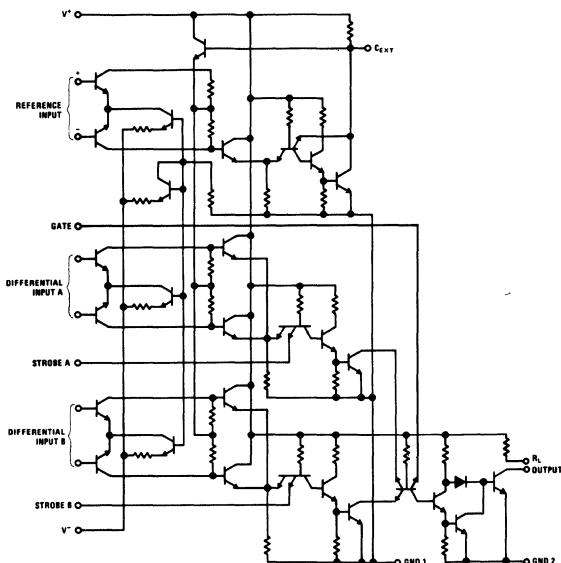
Note 3: Limits in parentheses pertain to LM7523, other limits pertain to LM7522

Note 4: Positive current is defined as current into the referenced pin

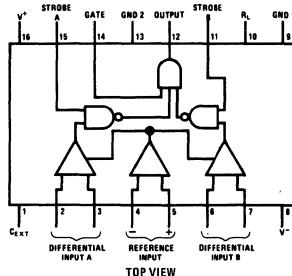
Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground

LM5522/LM7522 and LM5523/LM7523

schematic diagram



connection diagram



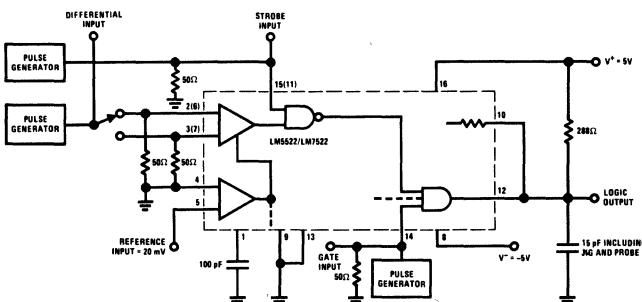
Order Number LM5522J or LM7522J
See Package 17

Order Number LM7522N
See Package 23

Order Number LM5523J or LM7523J
See Package 17

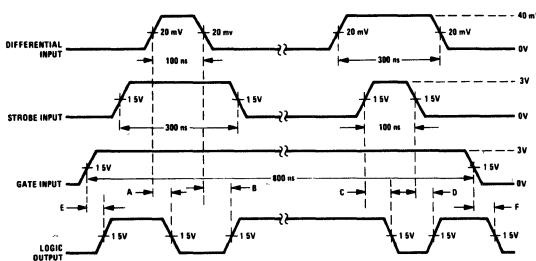
Order Number LM7523N
See Package 23

AC test circuit



7

voltage waveforms



1. One strobe is grounded when the other side is being tested

2. Pulse generator characteristics.

$Z_{OUT} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz

3. Propagation delays:

A = Differential input to logical "0" output

B = Differential input to logical "1" output

C = Strobe input to logical "0" output

D = Strobe input to logical "1" output

E = Gate input to logical "1" output

F = Gate input to logical "0" output

LM5524/LM7524 and LM5525/LM7525 electrical characteristics

LM5524/LM5525: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)						
					DIFF. INPUT	REF. INPUT	STROBE INPUT	LOGIC OUTPUT	SUPPLY VOLT.	COMMENTS	
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8)	15	20(22)	mV	$\pm V_{TH}$	15 mV	+5V	+16 mA	$\pm 5\text{V}$	Logic Output <0 4V	
	35(33)	15		mV	$\pm V_{TH}$	15 mV	+5V	-400 μA	$\pm 5\text{V}$	Logic Output >2 4V	
Differential & Reference Input Bias Current	30	100	μA	0V	0V	+5 25V	+5V	+16 mA	$\pm 5\text{V}$	Logic Output <0 4V	
								-400 μA	$\pm 5\text{V}$	Logic Output >2 4V	

LM7524/LM7525: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8)	15	19(22)	mV-	$\pm V_{TH}$	15 mV	+5V	+16 mA	$\pm 5\text{V} \pm 5\%$	Logic Output <0 4V	
	36(33)	15		mV	$\pm V_{TH}$	15 mV	+5V	-400 μA	$\pm 5\text{V} \pm 5\%$	Logic Output >2 4V	
Differential & Reference Input Bias Current	40	40	44(47)	mV	$\pm V_{TH}$	40 mV	+5V	+16 mA	$\pm 5\text{V} \pm 5\%$	Logic Output <0 4V	
	40	40		mV	$\pm V_{TH}$	40 mV	+5V	-400 μA	$\pm 5\text{V} \pm 5\%$	Logic Output >2 4V	

LM5524/LM5525: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7524/LM7525: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Diff. Input Offset Current		0.5		μA	0V	0V	+5 25V		$\pm 5\text{V}$	Logic Output >2 4V	
Logic "1" Input Voltage	2		0.8	V	40 mV	20 mV	+2V	-400 μA	$\pm 5\text{V}$	Logic Output <0.4V	
Logic "0" Input Voltage				V	40 mV	20 mV	+0.8V	+16 mA	$\pm 5\text{V}$		
Logic "0" Input Current		-1	-1.6	mA	40 mV	20 mV	+0.4V		$\pm 5\text{V}$		
Logic "1" Input Current	5	40	0.02	μA	0V	20 mV	+2 4V		$\pm 5\text{V}$		
		0.02	1	mA	0V	20 mV	+5.25V		$\pm 5.25\text{V}$		
Logic "1" Output Voltage	2.4	3.9		V	40 mV	20 mV	+2 0V	-400 μA	$\pm 4.75\text{V}$		
Logic "0" Output Voltage		0.25	0.40	V	40 mV	20 mV	+0.8V	+16 mA	$\pm 4.75\text{V}$		
Output Short Circuit Current	-2.1	-2.8	-3.5	mA	40 mV	20 mV	+5 25V	0V	$\pm 5.25\text{V}$		
V ⁺ Supply Current		29	40	mA	0V	20 mV	0V		$\pm 5.25\text{V}$		
V ⁻ Supply Current		-13	-18	mA	0V	20 mV	0V		$\pm 5.25\text{V}$		

LM5524/LM5525 and LM7524/LM7525: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE		AC Test Circuit	
Propagation Delays										AC Test Circuit	
Differential Input to Logical "1" Output	20	40		ns		20 mV				AC Test Circuit	
Differential Input to Logical "0" Output	28			ns		20 mV				AC Test Circuit	
Strobe Input to Logical "1" Output	10	30		ns		20 mV				AC Test Circuit	
Strobe Input to Logical "0" Output	20			ns		20 mV				AC Test Circuit	
Differential Input Overload Recovery Time	10			ns						AC Test Circuit	
Common-Mode Input Overload Recovery Time	5			ns							
Min. Cycle Time	200			ns							

Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5524 and LM5525 are guaranteed the same as LM7524 and LM7525 respectively.

Note 2: Limits in parentheses pertain to LM5525, other limits pertain to LM5524.

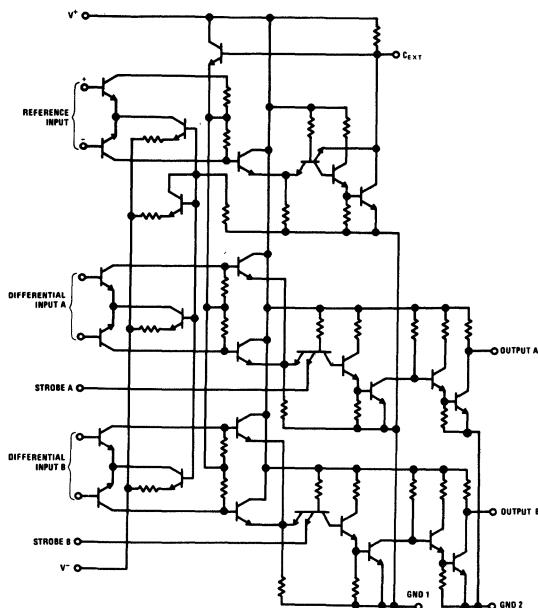
Note 3: Limits in parentheses pertain to LM7525, other limits pertain to LM7524.

Note 4: Positive current is defined as current into the referenced pin.

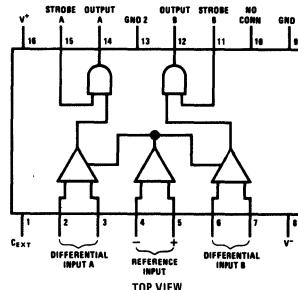
Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.

LM5524/LM7524 and LM5525/LM7525

schematic diagram



connection diagram



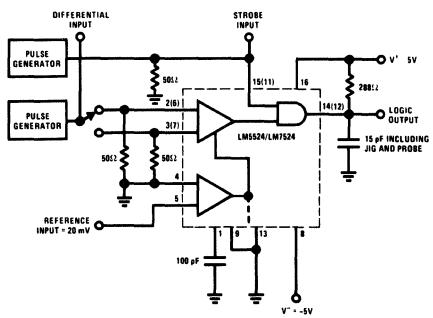
Order Number LM5524J or LM7524J
See Package 17

Order Number LM5524N
See Package 23

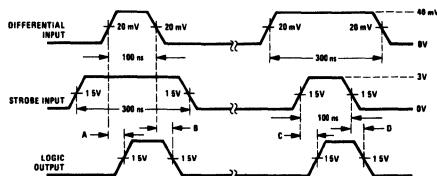
Order Number LM5525J or LM7525J
See Package 17

Order Number LM7525N
See Package 23

AC test circuit



voltage waveforms



1. Pulse generator characteristics:
 $Z_{out} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz
2. Propagation delays:
 - A = Differential input to logical "1" output
 - B = Differential input to logical "0" output
 - C = Strobe input to logical "1" output
 - D = Strobe input to logical "0" output

LM5528/LM7528 and LM5529/LM7529 electrical characteristics

LM5528/LM5529: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)						COMMENTS
					DIFF. INPUT	REF. INPUT	STROBE INPUT	LOGIC OUTPUT	SUPPLY VOLT.		
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8) 35(33)	15 40 40	20(22) 45(47)	mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV	+5V +5V +5V	+16 mA -400 μA +16 mA	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output $< 0\text{ V}$ Logic Output $> 2\text{ V}$ Logic Output $< 0\text{ V}$ Logic Output $> 2\text{ V}$	
Differential & Reference Input Bias Current		30	100	μA	0V	0V	+5.25V			$\pm 5.25\text{V}$	

LM7528/LM7529: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8) 36(33)	15 40 40	19(22) 44(47)	mV mV mV	$\pm V_{TH}$ $\pm V_{TH}$ $\pm V_{TH}$	15 mV 15 mV 40 mV	+5V +5V +5V	+16 mA -400 μA +16 mA	$\pm 5\text{V}$ $\pm 5\text{V}$ $\pm 5\text{V}$	Logic Output $< 0\text{ V}$ Logic Output $> 2\text{ V}$ Logic Output $< 0\text{ V}$ Logic Output $> 2\text{ V}$	
Differential & Reference Input Bias Current		30	75	μA	0V	0V	+5.25V			$\pm 5.25\text{V}$	

LM5528/LM5529: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7528/LM7529: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Diff. Input Offset Current		0.5		μA	0V	0V	+5.25V		$\pm 5.25\text{V}$		
Logic "1" Input Voltage	2		0.8	V	40 mV	20 mV	+2V	-400 μA	$\pm 5\text{V}$	Logic Output $> 2\text{ V}$	
Logic "0" Input Voltage			-1	-1.6	mA	40 mV	20 mV	+0.8V	+16 mA	$\pm 5\text{V}$	Logic Output $< 0\text{ V}$
Logic "0" Input Current			5	40	μA	0V	20 mV	+2.4V		$\pm 5.25\text{V}$	
Logic "1" Input Current			0.02	1	mA	0V	20 mV	+5.25V		$\pm 5.25\text{V}$	
Logic "1" Output Voltage	2.4	3.9		V	40 mV	20 mV	+2.0V	-400 μA	$\pm 4.75\text{V}$		
Logic "0" Output Voltage		0.25	0.40	V	40 mV	20 mV	+0.8V	+16 mA	$\pm 4.75\text{V}$		
Output Short Circuit Current	-2.1	-2.8	-3.5	mA	40 mV	20 mV	+5.25V	0V	$\pm 5.25\text{V}$		
V^+ Supply Current		29	40	mA	0V	20 mV	0V		$\pm 5.25\text{V}$		
V^- Supply Current		-13	-18	mA	0V	20 mV	0V		$\pm 5.25\text{V}$		

LM5528/LM5529 and LM7528/LM7529: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE			
Propagation Delays		20	40	ns		20 mV				AC Test Circuit	
Differential Input to Logical "1" Output		28		ns		20 mV				AC Test Circuit	
Differential Input to Logical "0" Output		28		ns		20 mV				AC Test Circuit	
Strobe Input to Logical "1" Output		10	30	ns		20 mV				AC Test Circuit	
Strobe Input to Logical "0" Output		20		ns		20 mV				AC Test Circuit	
Differential Input Overload Recovery Time		10		ns							
Common-Mode Input Overload Recovery Time		5		ns							
Min. Cycle Time		200		ns							

Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5528 and LM5529 are guaranteed the same as LM7528 and LM7529 respectively.

Note 2: Limits in parentheses pertain to LM5529, other limits pertain to LM5528.

Note 3: Limits in parentheses pertain to LM7529, other limits pertain to LM7528.

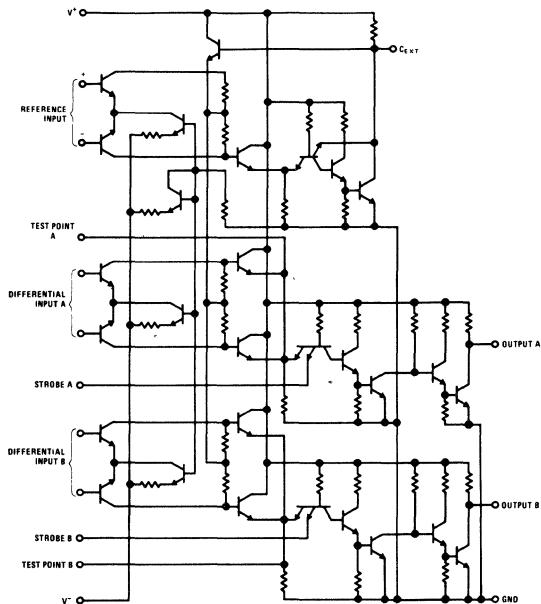
Note 4: Positive current is defined as current into the referenced pin.

Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.

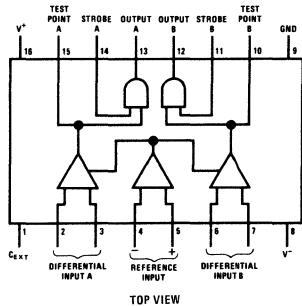
Note 6: Each test point to have $\leq 15\text{ pF}$ capacitive load to ground.

LM5528/LM7528 and LM5529/LM7529

schematic diagram



connection diagram



Order Number LM5528J or LM7528J

See Package 17

Order Number LM7528N

See Package 23

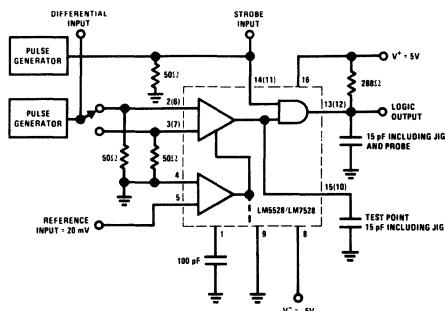
Order Number LM5529J or LM7529J

See Package 17

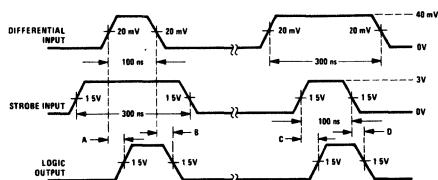
Order Number LM7529N

See Package 23

AC test circuit



voltage waveforms



1 Pulse generator characteristics

$Z_{OUT} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz

2 Propagation delays

- A = Differential input to logical "1" output
- B = Differential input to logical "0" output
- C = Strobe input to logical "1" output
- D = Strobe input to logical "0" output

LM5534/LM7534 and LM5535/LM7535 electrical characteristics

LM5534/LM5535: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)						COMMENTS
					DIFF. INPUT	REF. INPUT	STROBE INPUT	LOGIC OUTPUT	SUPPLY VOLT.		
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8)	15		mV	$\pm V_{TH}$	15 mV	+5V	+5 25V	$\pm 5\text{V}$		Logic Output $< 250\text{ }\mu\text{A}$
	35(33)	40	20(22)	mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5\text{V}$		Logic Output $< 0.4\text{V}$
		40	45(47)	mV	$\pm V_{TH}$	40 mV	+5V	+5 25V	$\pm 5\text{V}$		Logic Output $< 250\text{ }\mu\text{A}$
Differential & Reference Input Bias Current		30	100	μA	0V	0V	+5 25V		+5 25V		Logic Output $< 0.4\text{V}$

LM7534/LM7535: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8)	15	19(22)	mV	$\pm V_{TH}$	15 mV	+5V	+5.25V	$\pm 5\text{V}$		Logic Output $< 250\text{ }\mu\text{A}$
	36(33)	40	44(47)	mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5\text{V}$		Logic Output $< 0.4\text{V}$
Differential & Reference Input Bias Current		30	75	μA	0V	0V	+5 25V	+5.25V	$\pm 5\text{V}$		Logic Output $< 250\text{ }\mu\text{A}$

LM5534/LM5535: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7534/LM7535: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Diff. Input Offset Current		0.5		μA	0V	0V	+5 25V		$\pm 25\text{V}$		
Logic "0" Input Voltage			0.8	V	40 mV	20 mV	+0.8V	+5.25V	$\pm 5\text{V}$		Logic Output $< 250\text{ }\mu\text{A}$
Logic "1" Input Voltage	2.0			V	40 mV	20 mV	+2.0V	+20 mA	$\pm 5\text{V}$		Logic Output $< 0.4\text{V}$
Logic "0" Input Current		-1	-1.6	mA	40 mV	20 mV	+0.4V				$\pm 25\text{V}$
Logic "1" Input Current		5	40	μA	0V	20 mV	+2.4V				$\pm 25\text{V}$
		0.02	1	mA	0V	20 mV	+5 25V				$\pm 25\text{V}$
Logic "0" Output Voltage		0.25	0.40	V	40 mV	20 mV	+2V	+20 mA	$\pm 4.75\text{V}$		
Output Leakage Current		0.01	250	μA	40 mV	20 mV	+0.8V	+5 25V	$\pm 75\text{V}$		
V^+ Supply Current		28	38	mA	0V	20 mV	0V				$\pm 25\text{V}$
V^- Supply Current		-13	-18	mA	0V	20 mV	0V				$\pm 25\text{V}$

LM5534/LM5535 and LM7534/LM7535: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE			
Propagation Delays		24		ns		20 mV					AC Test Circuit
Differential Input to Logical "1" Output		20	40	ns		20 mV					AC Test Circuit
Differential Input to Logical "0" Output		16		ns		20 mV					AC Test Circuit
Strobe Input to Logical "1" Output		10	30	ns		20 mV					AC Test Circuit
Strobe Input to Logical "0" Output		5		ns		20 mV					AC Test Circuit
Differential Input Overload Recovery Time		10		ns							
Common-Mode Input Overload Recovery Time		200		ns							

Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5534 and LM5535 are guaranteed the same as LM7534 and LM7535 respectively.

Note 2: Limits in parentheses pertain to LM5535, other limits pertain to LM5534.

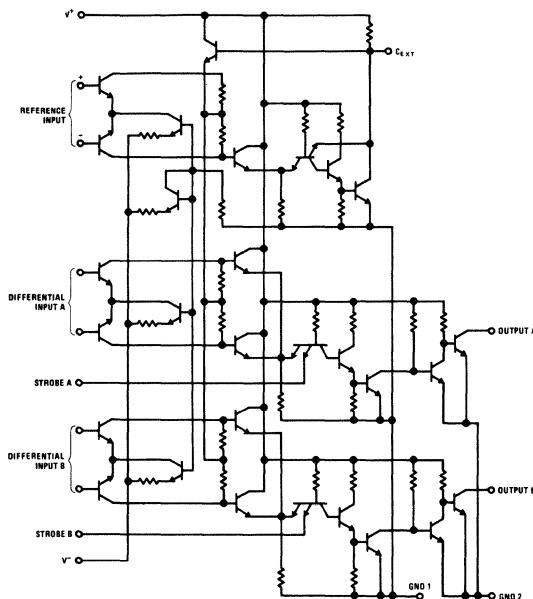
Note 3: Limits in parentheses pertain to LM7535, other limits pertain to LM7534.

Note 4: Positive current is defined as current into the referenced pin.

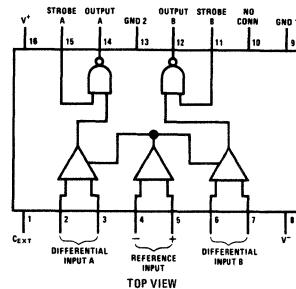
Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.

LM5534/LM7534 and LM5535/LM7535

schematic diagram



connection diagram



Order Number LM5534J or LM7534J

See Package 17

Order Number LM7534N

See Package 23

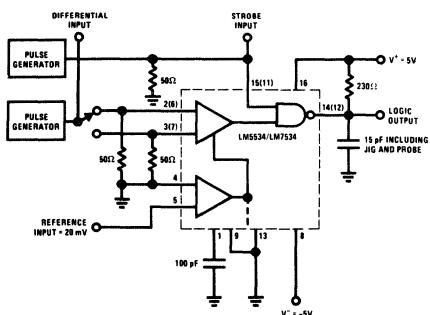
Order Number LM5535J or LM7535J

See Package 17

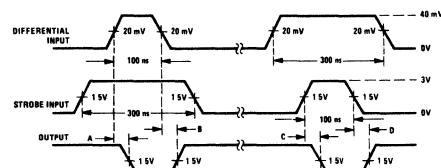
Order Number LM7535N

See Package 23

AC test circuit



voltage waveforms



1. Pulse generator characteristics

$Z_{OUT} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz

2. Propagation delays.

A = Differential input to logical "0" output

B = Differential input to logical "1" output

C = Strobe input to logical "0" output

D = Strobe input to logical "1" output

LM5538/LM7538 and LM5539/LM7539 electrical characteristics

LM5538/LM5539: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$ (Note 1)

PARAMETER	MIN	TYP	MAX	UNIT	TEST CONDITIONS (EACH AMPLIFIER)						COMMENTS
					DIFF. INPUT	REF. INPUT	STROBE INPUT	LOGIC OUTPUT	SUPPLY VOLT.		
Differential Input Threshold Voltage (V_{TH}) (Note 2)	10(8)	15		mV	$\pm V_{TH}$	15 mV	+5V	+5.25V	$\pm 5\text{V}$	Logic Output <250 μA	
	15	20(22)		mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5\text{V}$	Logic Output <0.4V	
	35(33)	40		mV	$\pm V_{TH}$	40 mV	+5V	+5.25V	$\pm 5\text{V}$	Logic Output <250 μA	
	40	45(47)		mV	$\pm V_{TH}$	40 mV	+5V	+20 mA	$\pm 5\text{V}$	Logic Output <0.4V	
Differential & Reference Input Bias Current		30	100	μA	0V	0V	+5.25V		$\pm 5.25\text{V}$		

LM7538/LM7539: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Differential Input Threshold Voltage (V_{TH}) (Note 3)	11(8)	15	19(22)	mV	$\pm V_{TH}$	15 mV	+5V	+5.25V	$\pm 5\text{V}$	Logic Output <250 μA
	15	20(22)		mV	$\pm V_{TH}$	15 mV	+5V	+20 mA	$\pm 5\text{V}$	Logic Output <0.4V
	36(33)	40	44(47)	mV	$\pm V_{TH}$	40 mV	+5V	+5.25V	$\pm 5\text{V}$	Logic Output <250 μA
Differential & Reference Input Bias Current		30	75	μA	0V	0V	+5.25V		$\pm 5.25\text{V}$	Logic Output <0.4V

LM5538/LM5539: The following apply for $-55^{\circ}\text{C} \leq T_A \leq 125^{\circ}\text{C}$

LM7538/LM7539: The following apply for $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$

Diff. Input Offset Current	2	0.5		μA	0V	0V	+5.25V		$\pm 5.25\text{V}$	Logic Output <0.4V
Logic "1" Input Voltage										
Logic "0" Input Voltage		0.8	V	40 mV	20 mV	+2V	+20 mA	$\pm 5\text{V}$	$\pm 5\text{V}$	Logic Output <250 μA
Logic "0" Input Current										
Logic "1" Input Current		-1	-1.6	mA	40 mV	20 mV	+0.4V	$\pm 5.25\text{V}$	$\pm 5.25\text{V}$	$\pm 5.25\text{V}$
Logic "1" Input Current										
Logic "0" Output Voltage		5	40	μA	0V	20 mV	+2.4V		$\pm 5.25\text{V}$	
Output Leakage Current		0.02	1	mA	0V	20 mV	+5.25V		$\pm 5.25\text{V}$	
V^+ Supply Current		0.25	0.40	V	40 mV	20 mV	+2.0V	+20 mA	$\pm 4.75\text{V}$	
V^- Supply Current		0.01	250	μA	40 mV	20 mV	+0.8V	+5.25V	$\pm 4.75\text{V}$	
		28	38	mA	0V	20 mV	0V		$\pm 5.25\text{V}$	
		-13	-18	mA	0V	20 mV	0V		$\pm 5.25\text{V}$	

LM5538/LM5539 and LM7538/LM7539: The following apply for $T_A = 25^{\circ}\text{C}$, $V^+ = 5\text{V}$, $V^- = -5\text{V}$

AC Common-Mode Input Firing Voltage		± 2.5		V	PULSE	20 mV	+5V	SCOPE		AC Test Circuit
Propagation Delays										
Differential Input to Logical "1" Output		24	40	ns		20 mV				AC Test Circuit
Differential Input to Logical "0" Output										
Strobe Input to Logical "1" Output		16	30	ns		20 mV				AC Test Circuit
Strobe Input to Logical "0" Output										
Differential Input Over- load Recovery Time		10		ns		20 mV				AC Test Circuit
Common-Mode Input Overload Recovery Time		5		ns						AC Test Circuit
Min. Cycle Time		200		ns						

Note 1: For $0^{\circ}\text{C} \leq T_A \leq 70^{\circ}\text{C}$ operation, electrical characteristics for LM5538 and LM5539 are guaranteed the same as LM7538 and LM7539 respectively.

Note 2: Limits in parentheses pertain to LM5539, other limits pertain to LM5538.

Note 3: Limits in parentheses pertain to LM7539, other limits pertain to LM7538.

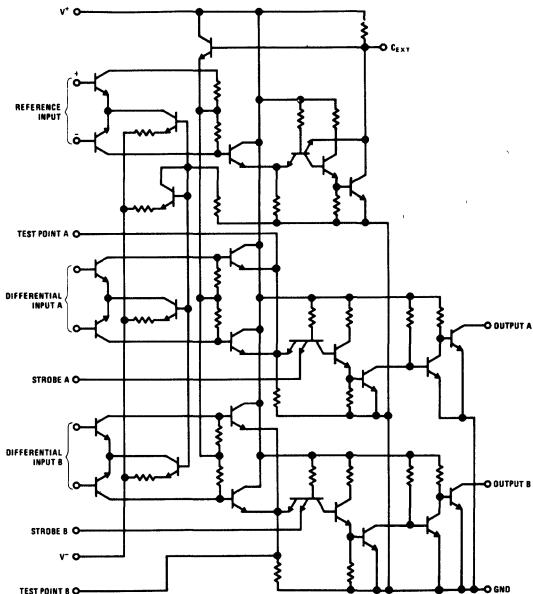
Note 4: Positive current is defined as current into the referenced pin.

Note 5: Pin 1 to have $\geq 100\text{ pF}$ capacitor connected to ground.

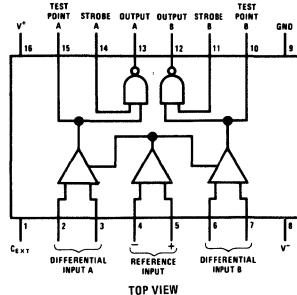
Note 6: Each test point to have $\leq 15\text{ pF}$ capacitive load to ground.

LM5538/LM7538 and LM5539/LM7539

schematic diagram



connection diagram



Order Number LM5538J or LM5538J

See Package 17

Order Number LM7538N

See Package 23

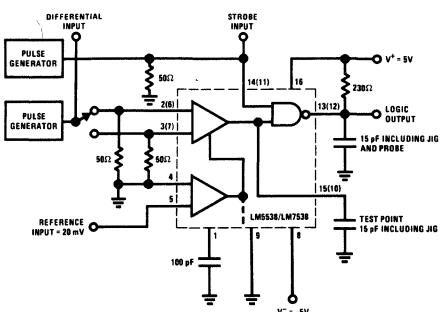
Order Number LM5539J or LM5539J

See Package 17

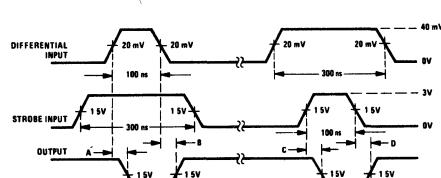
Order Number LM7539N

See Package 23

AC test circuit



voltage waveforms



1 Pulse generator characteristics

$Z_{out} = 50\Omega$, $t_r = t_f = 15 \pm 5$ ns, PRR = 1 MHz

2 Propagation delays

A = Differential input to logical "0" output

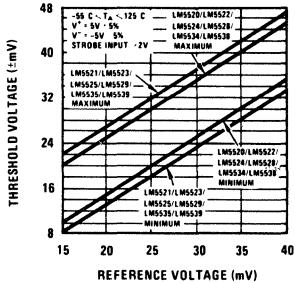
B = Differential input to logical "1" output

C = Strobe input to logical "0" output

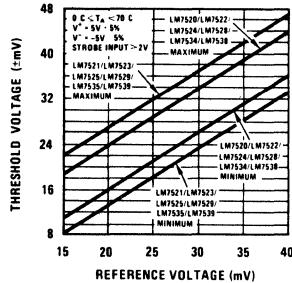
D = Strobe input to logical "1" output

guaranteed performance characteristics

Differential Input Threshold Voltage

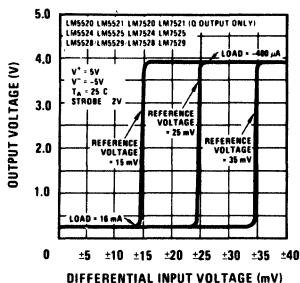


Differential Input Threshold Voltage

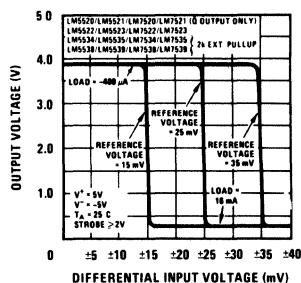


typical performance characteristics

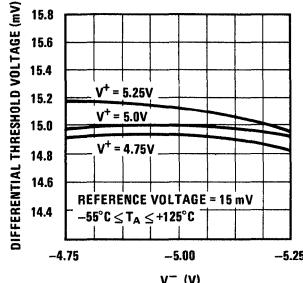
Transfer Characteristics



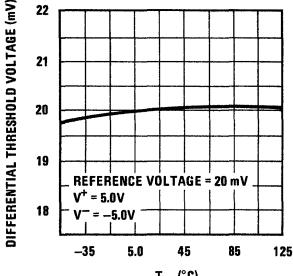
Transfer Characteristics



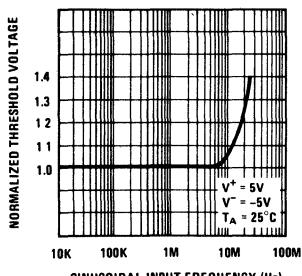
Power Supply Rejection



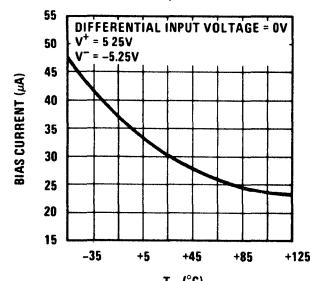
Temperature Coefficient



Differential Input Frequency Response

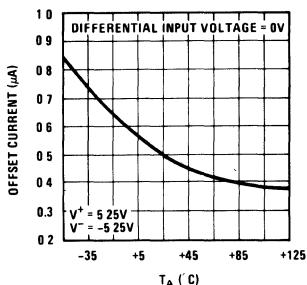


Differential Input Bias Current

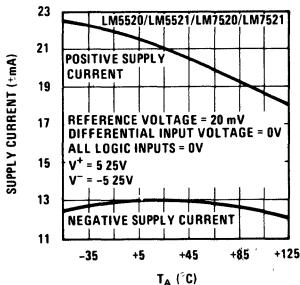


typical performance characteristics (cont.)

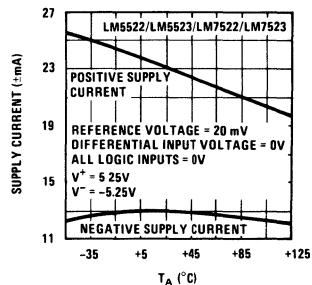
Differential Input Offset Current



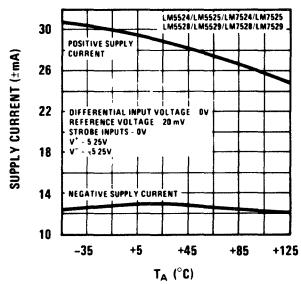
Power Supply Currents



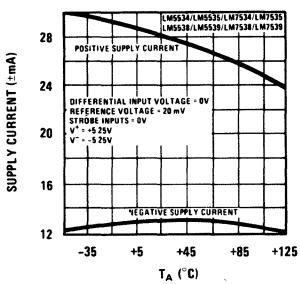
Power Supply Currents



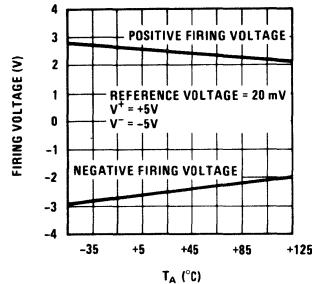
Power Supply Currents



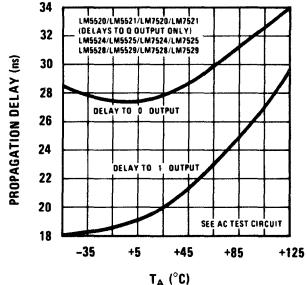
Power Supply Currents



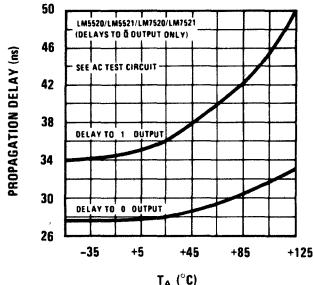
AC Common-Mode Firing Voltage



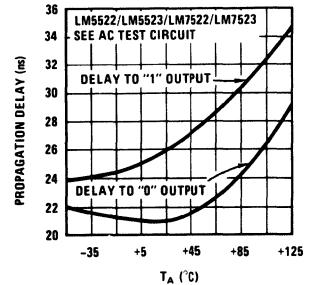
Differential Input to Output Propagation Delays



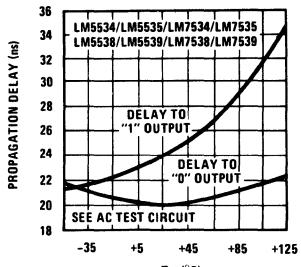
Differential Input to Output Propagation Delays



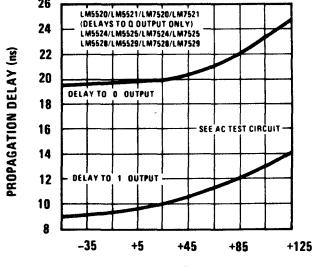
Differential Input to Output Propagation Delays



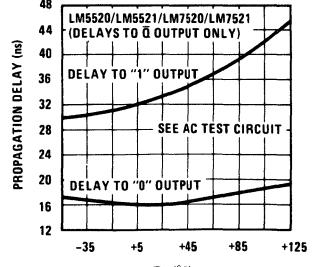
Differential Input to Output Propagation Delays



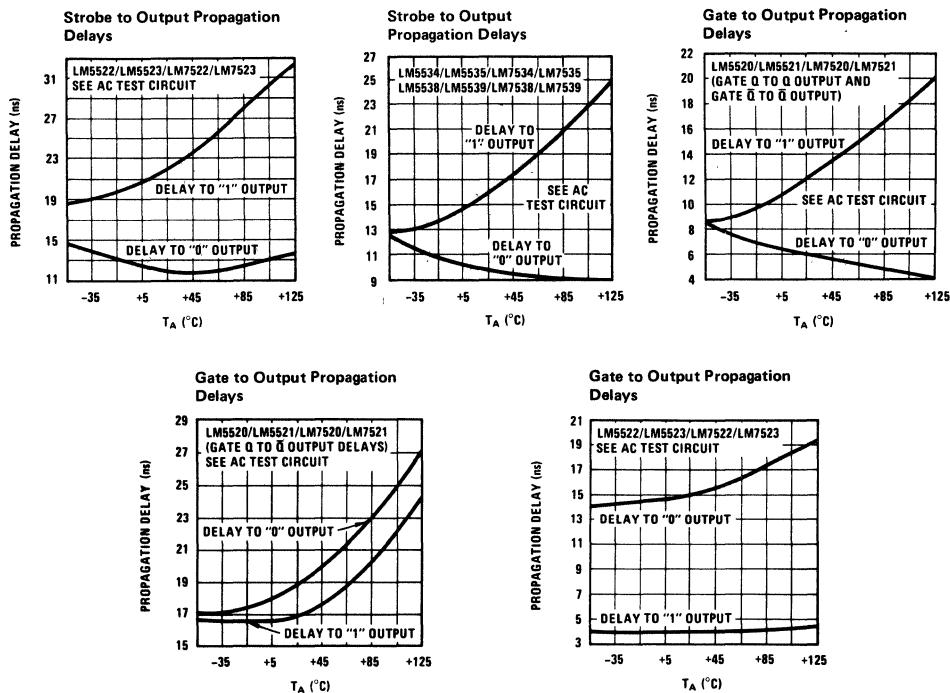
Strobe to Output Propagation Delays



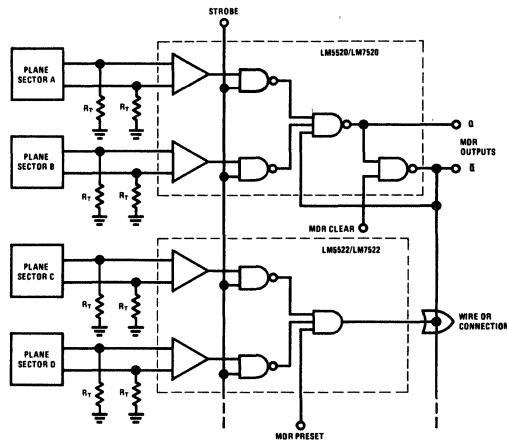
Strobe to Output Propagation Delays



typical performance characteristics (cont.)

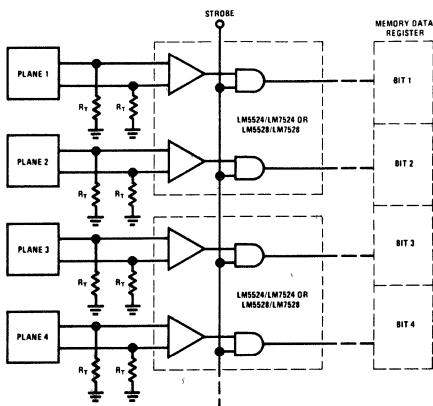


typical applications

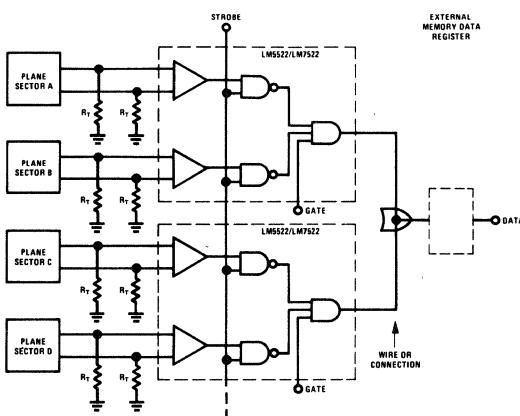


Large Memory System with Sected Core Planes

typical applications (cont.)



Small Memory System



Large Memory System